

Notice of References Cited	Application/Control No. 10/502,088	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Mark T. Vogelbacker	Art Unit 3677	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,406,678	04-1995	Rude et al.	16/342
*	B	US-5,402,150	03-1995	Stiles, William P.	345/168
*	C	US-5,195,213	03-1993	Ohgami et al.	16/342
*	D	US-5,079,799	01-1992	Rude et al.	16/342
*	E	US-6,553,625	04-2003	Lin et al.	16/342
*	F	US-5,500,982	03-1996	Hosoi, Takashi	16/297
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2002013522 A	01-2002	Japan	YAMADA et al.	F16C 11/10
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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